

# **PRODUCT SPECIFICATION**

# 6.2" Mono TFT LCD MODULE MODEL: T062640320-A0WMN-001 Ver:1.4

< >> Preliminary Specification

< ◆> Finally Specification

	CUSTOMER	R'S APPROVAL
CUSTOMER:		_
SIGN	ATURE:	DATE:

APPROVED	PM	PD	PREPARED
BY	REVIEWED	REVIEWED	BY

# **Revision History**

Revision	Date	Originator	Detail	Remarks
1.0	2013.04.19		Initial Release	
1.1	2013.05.11		Modify PIN1 assignment	P9,P10,P26
1.2	2013.08.21		Modify Resolution	P4
1.3	2014.04.28		Add weight Add current Modify Chromaticity Transmissive Modify Inspection Specification Modify Reliability Specification Modify Outline Drawing	P4 P5 P6 P17 P22 P26
1.4	2018.04.26	ZFY	Add LED working life Modify many details	P5 P23/P24

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## 1. General Description

The specification is a transmissive type color active matrix liquid crystal display (LCD) which uses amorphous thin film transistor (TFT) as switching devices. This product is composed of a TFT-LCD panel, driver lcs and a backlight unit.

## 2. Module Parameter

Features	Details	Unit
Display Size(Diagonal)	6.2"	
Display Mode	Transmissive / Normally Black VA	
Resolution	640 x 320	Pixels
View Direction	WIDE VIEW	Best Image
Module Outline	151.3(H) x 88.3(V) x 2.8(T) (Note1)	mm
Active Area	140 (H) x70(V)	mm
Pixel Pitch	218.75(H) x 218.75(V)	um
Pixel Arrangement	Mono Stripe	
Interface	8-bit 8080/8-bit 6800/3-line/4-line Interface	
Driver IC	ST7511	-
With or Without Touch Panel	Without	
Operating Temperature	-20~70	°C
Storage Temperature	-30~80	°C
Weight	82	g

Note 1: Exclusive hooks, posts, FFC/FPC tail etc.

## 3. Absolute Maximum Ratings

V<sub>SS</sub>=0V, Ta=25°C

Item	Symbol	Min.	Max.	Unit
Supply Voltage	VDDA	2.7	5.5	V
Supply Voltage	VDDI	2.7	5.5	V
Storage temperature	Tstg	-30	+80	°C
Operating temperature	Тор	-20	+70	°C

**Note 1:** If Ta below 50°C, the maximal humidity is 90%RH, if Ta over 50°C, absolute humidity should be less than 60%RH.

Note 2: The response time will be extremely slow when the operating temperature is around -10 $^{\circ}$ C, and the back ground will become darker at high temperature operating.

## 4. DC Characteristics

V<sub>SS</sub>=0V, Ta=25°C

Item		Symbol	Min.	Тур.	Max.	Unit
Supply Voltage		VDDA 3.0 3.3 5.0 V		V		
Supply Voltage		VDDI	3.0	3.3	5.0	V
Logic Low input voltage		V <sub>IL</sub>	GND	-	0.2*VDDI	V
Logic High input voltage		V <sub>IH</sub>	0.8*VDDI	-	VDDI	V
Logic Low output voltage		$V_{OL}$	GND	ı	0.2*VDDI	V
Logic High output voltage		$V_{OH}$	0.8*VDDI	ı	VDDI	V
Current Consumption	Logic	1 1		(30)	(50)	mA
All White	Analog	I <sub>CC+</sub> I <sub>IN</sub>	-	(30)	(30)	IIIA

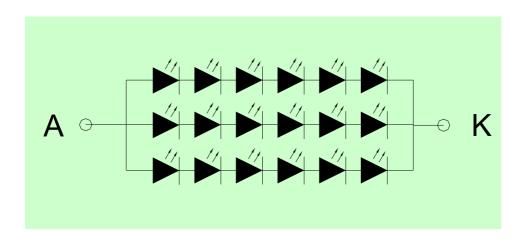
## 5. Backlight Characteristic

## 5.1. Backlight Characteristic

Item	Symbol	Condition	Min.	Тур.	Max.	Unit
Forward Voltage	VF	Ta=25 °C, I <sub>F</sub> =20mA/LED	17.4	19.2	19.8	V
Forward Current	lF	Ta=25 °C, V <sub>F</sub> =3.2V/LED	-	60	-	mA
Power dissipation	PD	-	-	1152	-	W
Uniformity	Avg	-	1	80	-	%
LED working life(25°C)	-		1	20000	-	Hrs
Drive method		Constant	current			
LED Configuration	18 V	Vhite LEDs (6 LEDs in one	string and	d 3 groups	in paralle	el)

Note1: LED life time defined as follows: The final brightness is at 50% of original brightness. The environmental conducted under ambient air flow, at  $Ta=25\pm2$  °C,60%RH $\pm5$ %,  $I_F=20$ mA

## 5.2. Backlighting circuit



# 6. Optical Characteristics

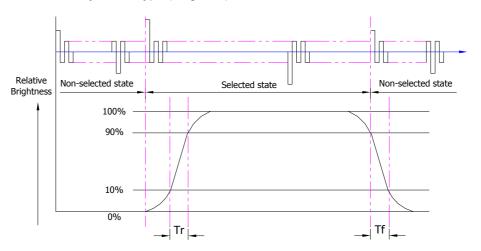
## 6.1. Optical Characteristics

Ta=25°C,

	Iter	<u> </u>	Symbol	Condition	S	pecificati	on	Unit
	itei	11	Symbol	Condition	Min.	Тур.	Max.	Unit
	Luminar	nce on						
<u> </u>	$TFT(I_f = 20)$	)mA/LED)	Lv		480	600	-	cd/m²
Backlight On (Transmissive Mode)	Contrast rati	o(See 6.3)	CR		-	TBD	-	
Σ ο	Respons	se time	Tr			TBD		mo
si×	(See	6.2)	TF		-	טפו		ms
πis		Red	XR			TBD		-
Insi		Neu	YR			TBD		-
Tra	Chromoticity	Green	XG			TBD		-
n (	Chromaticity Transmissive	516611	Yg	Backlight is on		TBD		-
t	(See 6.5)	Blue	Хв	Dacklight is on		TBD		-
lgi.	(366 0.3)	blue	YB			TBD		-
ack		White	Xw		0.234	0.284	0.334	-
æ		vviile	Yw		0.271	0.321	0.371	-
	Viewing	Horizontal	θх+		70	80	-	
	Viewing	TIONZONIAI	θх-	Center CR≥10	70	80	-	Dog
	Angle (See 6.4)	Vertical	φY+	Center CR210	70	80	-	Deg.
	(366 0.4)	vertical	фҮ-		70	80	-	
	NTSC Ratio	o(Gamut)	-	θ=0°	-	TBD	-	%

## 6.2. Definition of Response Time

## 6.2.1. Normally Black Type (Negative)

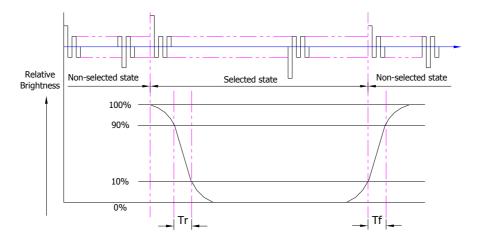


Tr is the time it takes to change form non-selected stage with relative luminance 10% to selected state with relative luminance 90%;

Tf is the time it takes to change from selected state with relative luminance 90% to non-selected state with relative luminance 10%.

Note: Measuring machine: LCD-5100

## 6.2.2. Normally White Type (Positive)



Tr is the time it takes to change form non-selected stage with relative luminance 90% to selected state with relative luminance 10%;

Tf is the time it takes to change from selected state with relative luminance 10% to non-selected state with relative luminance 90%;

Note: Measuring machine: LCD-5100 or EQUI

## 6.3. Definition of Contrast Ratio

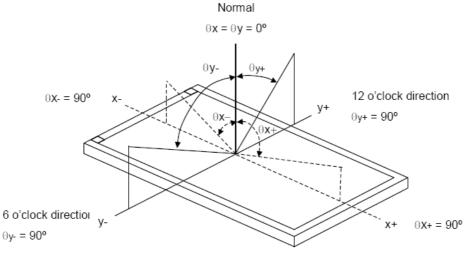
Contrast is measured perpendicular to display surface in reflective and transmissive mode.

The measurement condition is:

Measuring Equipment	Eldim or Equivalent
Measuring Point Diameter	3mm//1mm
Measuring Point Location	Active Area centre point
Toot nottorn	A: All Pixels white
Test pattern	B: All Pixel black
Contrast setting	Maximum

Definitions: CR (Contrast) = Luminance of White Pixel / Luminance of Black Pixel

## 6.4. Definition of Viewing Angles

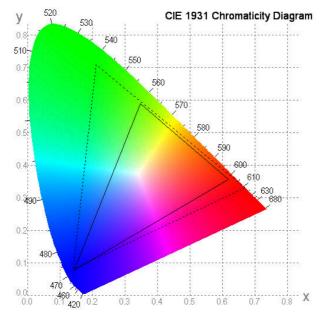


Measuring machine: LCD-5100 or EQUI

## 6.5. Definition of Color Appearance

R,G,B and W are defined by (x, y) on the IE chromaticity diagram NTSC=area of RGB triangle/area of NTSC triangleX100%

Measuring picture: Red, Green, Blue and White (Measuring machine: BM-7)

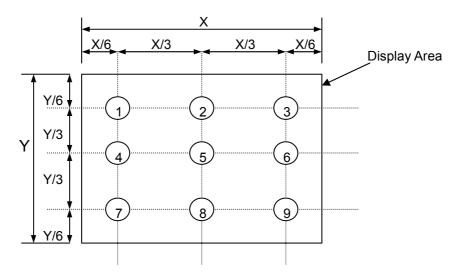


## 6.6. Definition of Surface Luminance, Uniformity and Transmittance

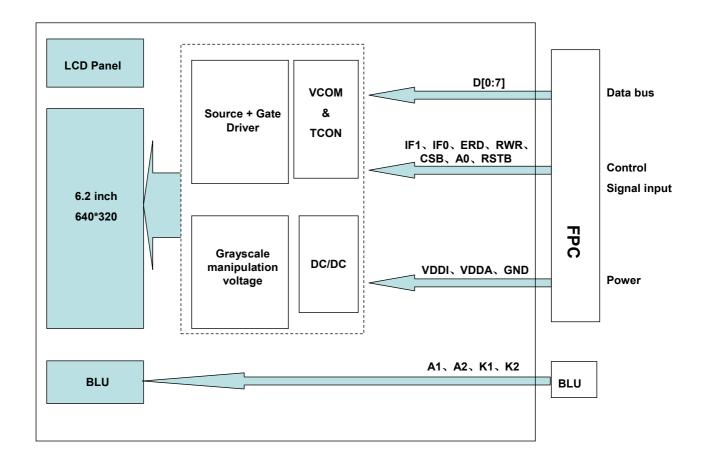
Using the transmissive mode measurement approach, measure the white screen luminance of the display panel and backlight.

- 6.6.1. Surface Luminance:  $L_V$  = average ( $L_{P1}$ : $L_{P9}$ )
- 6.6.2. Uniformity = Minimal  $(L_{P1}:L_{P9})$  / Maximal  $(L_{P1}:L_{P9})$  \* 100%
- 6.6.3. Transmittance =  $L_V$  on LCD /  $L_V$  on Backlight \* 100%

Note: Measuring machine: BM-7



# 7. Block Diagram and Power Supply



## 8. Interface Pins Definition

No.	Symbol	Function	Remark
1	GND	Ground	
2	GND	Ground	
3	VDDA	Power supply.	
4	VDDI	Power supply.	
5	D0		
6	D1	When using 8-bit parallel interface(6800 or 8080 mode):	
7	D2	8-bit bi-directional data bus.	
8	D3	When using perial interface:2 line or 4 line:	
9	D4	When using serial interface:3-line or 4-line:  D7: Serial input clock (SCL).	
10	D5	D0: Serial data (SDA).	
11	D6	D[6:1]:fix to "H" by VDDI.	
12	D7		
13	NC	No connection	
14	NC	No connection	
15	NC	No connection	
16	NC	No connection	
17	NC	No connection	
18	NC	No connection	
19	NC	No connection	
20	NC	No connection	
21	NC	No connection	
22	NC	No connection	
23	NC	No connection	
24	NC	No connection	
25	NC	No connection	
26	NC	No connection	
27	NC	No connection	
28	NC	No connection	
29	GND	Ground	
30	NC	No connection	
31	NC	No connection	
32	GND	Ground	
33	NC	No connection	
34	NC	No connection	
35	RSTB	Reset input pin.	
36	NC	No connection	
37	A0	Data/Command identification pin	
38	CSB	Chip select input pin	

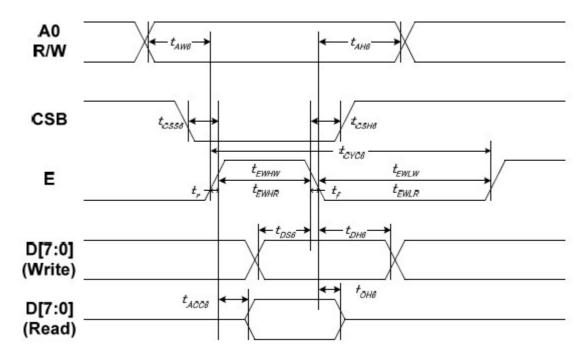
I	Ī	I					
		Read/\	Vrite	execution	n control	pin. When IF1 is "L".	
20	RWR	IF0	MF	PU Type	ERD	Description	
39	RVVR	Н	680	00 series	Е	Read/Write control input pin.	
		L	808	30 series	/RD	Read enable input pin	
			Re	ad/Write e	execution	n control pin. When IF1 is "L".	
40	EDD	IF0	MF	PU Type	ERD	Description	
40	ERD	Н	680	00 series	R/W	Read/Write control input pin.	
		L	808	30 series	WR	Write enable input pin	
41	NC	No cor	nnect	tion			
42	NC	No cor	nect	tion			
43	IF0	IF1	1	IF0		Selected Interface	
		L		L	8-bit 80	080 parallel interface	
		L		Н	8-bit 68	8-bit 6800 parallel interface	
		Н		L	3-line s	serial interface	
44	IF1	Н		Н	4-line s	serial interface	
45	NC	No cor	nnect	tion			
46	NC	No connection					
47	GND	Groun	d				
48	GND	Groun	Ground				
49	NC	No cor	nnect	tion			
50	NC	No cor	nnect	tion			

## PIN2 assignment

No.	Symbol	Function	Remark
1	A1	LED Anode.	
2	A2	LED Anode.	
3	K1	LED Cathode.	
4	K2	LED Cathode.	

## 9. AC Characteristics

## 9.1. System Bus Timing for 6800 Series MPU

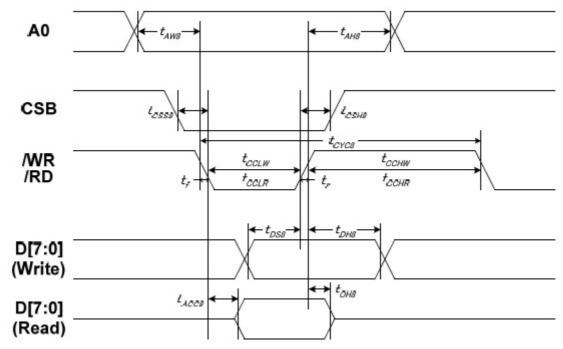


VDD1 = 3.3V~5.0V , Ta = 25℃

Item	Signal	Symbol	Condition	Min.	Max.	Unit
Address setup time	40	tAW6		10	0.000	
Address hold time	A0	tAH6		0	1000	1
System cycle time		tCYC6	88	1100	_	1
Enable L pulse width (WRITE)		tEWLW		500	1000	1
Enable H pulse width (WRITE)	E	tEWHW	2	500	(	1
Enable L pulse width (READ)		tEWLR		500	1 <del></del>	1
Enable H pulse width (READ)	100	tEWHR		500	1000	ns
CSB setup time	CSB	tCSS6		100	_	
CSB hold time	CSB	tCSH6		100		1
Write data setup time	7	tDS6	©.	200	-	1
Write data hold time	D(7:01	tDH6		60	3.75.25	1
Read data access time	D[7:0]	tACC6	CL = 100 pF	_	950	1
Read data output disable time		tOH6	CL = 100 pF	5	200	1

- The input signal rise time and fall time (tr, tf) is specified at 15 ns or less. When the system cycle time is extremely fast, (tr + tf) ≤ (tCYC8 – tCCLW – tCCHW) for (tr + tf) ≤ (tCYC8 – tCCLR – tCCHR) are specified.
- 2. All timing is specified using 20% and 80% of VDD1 as the reference.
- tCCLW and tCCLR are specified as the overlap between CSB being "L" and /WR and /RD being at the "L" level.
   CSB and /WR (or /RD) cannot act at the same time and CSB should be 100ns widther than /WR (or /RD).

## 9.2. System Bus Timing for 8080 Series MPU

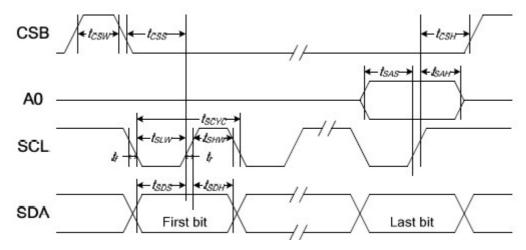


VDD1 = 3.3V~5.0V , Ta = 25℃

Item	Signal	Symbol	Condition	Min.	Max.	Unit
Address setup time	A0	tAW8		10	<u> </u>	
Address hold time	AU	tAH8	28	0		]
System cycle time	50	tCYC8		1100	10-30	1
/WR L pulse width (WRITE)	WR	tCCLW		500	_	1
/WR H pulse width (WRITE)		tCCHW		500	1-0	1
/RD L pulse width (READ)	(DD	tCCLR		950	<u> </u>	1
/RD H pulse width (READ)	/RD	tCCHR		500	3 <del>-</del> 3	ns
CSB setup time	CSB	tCSS8		100	15 (0)	1
CSB hold time	CSB	tCSH8		100	_	1
WRITE Data setup time		tDS8		200	10-30	1
WRITE Data hold time	D(7:0)	tDH8	2	50	10_3	1
READ access time	D[7:0]	tACC8	CL = 100 pF	_	950	1
READ Output disable time		tOH8	CL = 100 pF	5	200	1

- The input signal rise time and fall time (tr, tf) is specified at 15 ns or less. When the system cycle time is extremely fast, (tr + tf) ≤ (tCYC8 – tCCLW – tCCHW) for (tr + tf) ≤ (tCYC8 – tCCLR – tCCHR) are specified.
- 2. All timing is specified using 20% and 80% of VDD1 as the reference.
- tCCLW and tCCLR are specified as the overlap between CSB being "L" and /WR and /RD being at the "L" level.
   CSB and /WR (or /RD) cannot act at the same time and CSB should be 100ns widther than /WR (or /RD).

## 9.3. System Bus Timing for 4-line Serial MPU

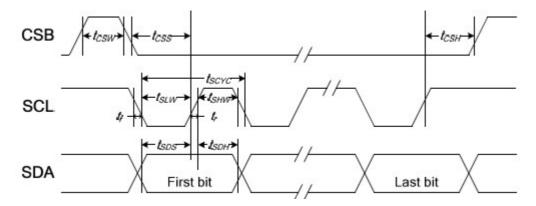


VDD1 = 3.3V~5.0V , Ta = 25℃

Item	Signal	Symbol	Condition	Min.	Max.	Unit
Serial clock period		tSCYC		250		
SCL "H" pulse width	SCL	tSHW		100	200	1
SCL "L" pulse width		tSLW		100	_	1
Address setup time	A0	tSAS		150	200	1
Address hold time	Au	tSAH	16	150	_	
Data setup time	SDA.	tSDS		100		ns
Data hold time	SDA	tSDH		100	_	1
CSB-SCL time		tCSS		150	-	1
CSB-SCL time	CSB	tCSH		150	2002	1
CSB "H" pulse width		tCSW		25	-	1

- 1. The input signal rise and fall time (tr, tf) are specified at 15 ns or less.
- 2. All timing is specified using 20% and 80% of VDD1 as the standard.

## 9.4. System Bus Timing for 3-line Serial MPU



VSS=0V, VDDI = VDDA=2.7 ~ 5.5V, Ta = -40 ~ 105℃

Item	Signal	Symbol	Condition	Min.	Max.	Unit
Serial Clock Period		tSCYC		250	s s <del>-</del> s s	
SCL "H" pulse width	SCL	tSHW		100		
SCL "L" pulse width		tSLW	į.	100	-	1
Data setup time	SD4	tSDS		100		1
Data hold time	SDA	tSDH		100		ns
CSB-SCL time		tCSS		150	55 <del>7</del> 6	1
CSB-SCL time	CSB	tCSH	3	150	-	1
CSB "H" pulse width		tCSW		10		1

- 1. The input signal rise and fall time (tr, tf) are specified at 15 ns or less.
- 2. All timing is specified using 20% and 80% of VDD1 as the standard.

## 10. Quality Assurance

#### 10.1 Purpose

This standard for Quality Assurance assures the quality of LCD module products supplied to customer.

## 10.2 Standard for Quality Test

10.2.1 Sampling Plan:

GB2828.1-2012

Single sampling, normal inspection.

10.2.2 Sampling Criteria:

Visual inspection: AQL 1.5%

Electrical functional: AQL 0.65%.

10.2.3 Reliability Test:

Detailed requirement refer to Reliability Test Specification.

#### 10.3 Nonconforming Analysis & Disposition

- 10.3.1 Nonconforming analysis:
  - 10.3.1.1 Customer should provide overall information of non-conforming sample for their complaints.
  - 10.3.1.2 After receipt of detailed information from customer, the analysis of nonconforming parts usually should be finished in one week.
  - 10.3.1.3 If cannot finish the analysis on time, customer will be notified with the progress status.
- 10.3.2 Disposition of nonconforming:
  - 10.3.2.1 Non-conforming product over PPM level will be replaced.
  - 10.3.2.2 The cause of non-conformance will be analyzed. Corrective action will be discussed and implemented.

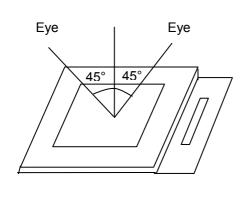
#### 10.4 Agreement Items

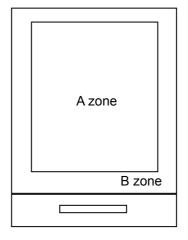
Shall negotiate with customer if the following situation occurs:

- 10.4.1 There is any discrepancy in standard of quality assurance.
- 10.4.2 Additional requirement to be added in product specification.
- 10.4.3 Any other special problem.

#### 10.5 Standard of the Product Visual Inspection

- 10.5.1 Appearance inspection:
  - 10.5.1.1 The inspection must be under illumination about 1000 1500 lx, and the distance of view must be at 30cm ± 2cm.
  - 10.5.1.2 The viewing angle should be 45° from the vertical line without reflection light or follows customer's viewing angle specifications.
  - 10.5.1.3 Definition of area: A Zone: Active Area, B Zone: Viewing Area,



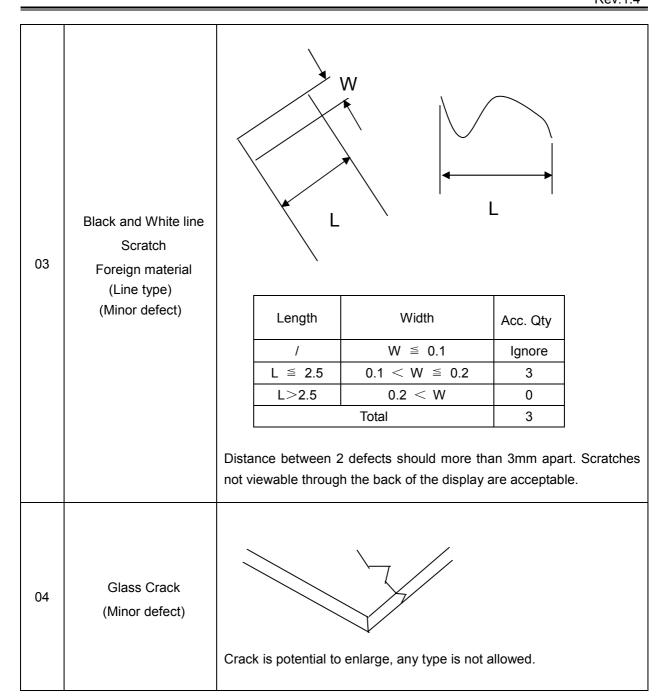


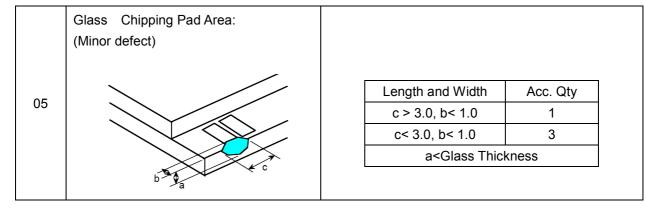
## 10.5.2 Basic principle:

- 10.5.2.1 A set of sample to indicate the limit of acceptable quality level must be discussed by both us and customer when there is any dispute happened.
- 10.5.2.2 New item must be added on time when it is necessary.

## 10.6 Inspection Specification

No.	Item	Criteria (Unit: mm)				
01	Black / White spot Foreign material (Round type) Pinholes Stain Particles inside cell. (Minor defect)	$\phi$ = (a + b)/2 Distance between 2 de	0.20<0	€0.20 p≤0.50 0<φ	Acc. Qty  Ignore  N≤3 0	
		Bright dot	Display Area N≤2	Total N≤2	Note 4	
		Dark dot	N≤4	N≤4	Note1	
02	Electrical Defect	Total dot	N≤4	N≤4		
	(Minor defect)	Mura		rough 5% ND ter.	Note 2	
		Remark: 1. Bright dot caused by	scratch and for	reign object acco	rds to item 1.	





	Glass Chipping Rear of Pad Area:			
	(Minor defect)	Г	Length and Width	Acc. Qty
06			c > 3.0, b< 1.0	1
			c< 3.0, b< 1.0	2
			c< 3.0, b< 0.5	4
			a <glass td="" thick<=""><td></td></glass>	
	b 2 a			
	Glass Chipping Except Pad Area: (Minor defect)			
			Length and Width	Acc. Qty
			c > 3.0, b< 1.0	1
07			c< 3.0, b< 1.0	2
			c< 3.0, b< 0.5	4
			a <glass td="" thic<=""><td>kness</td></glass>	kness
	a			
	Glass Corner Chipping: (Minor defect)			
	(Millor defect)	Г	Length and Width	Acc. Qty
			c < 3.0, b< 3.0	Ignore
08			a <glass td="" thick<=""><td></td></glass>	
			<u> </u>	
	ba			
	Glass Burr:			
	(Minor defect)			
	F		Length	Acc. Qty
09	_		F < 1.0	Ignore
	F —	Glass	burr don't affect as	semble and module
		dimens		

10	FPC Defect: (Minor defect)		<ul><li>10.1 Dent, pinhole width a<w 3.<="" li=""><li>(w: circuitry width.)</li><li>10.2 Open circuit is unacceptable.</li><li>10.3 No oxidation, contamination and distortion.</li></w></li></ul>		
11	Bubble on Polarizer (Minor defect)		Diameter φ≤0.30 0.30 <φ≤0.50 0.50 < φ	Acc. Qty Ignore N≤2 N=0	
12	Dent on Polarizer (Minor defect)		Diameter φ≤0.25 0.25 <φ≤0.50 0.50 < φ	Acc. Qty Ignore N≤4 None	
13	Bezel	13.1 No rust, distor 13.2 No visible fing	tion on the Bezel. erprints, stains or othe	er contamination.	
14	Touch Panel	D: Diameter W: width L: length  14.1 Spot: D<0.25 is acceptable  0.25 ≤ D ≤ 0.4  2dots are acceptable and the distance between defects should more tha  10 mm.  D>0.4 is unacceptable  14.2 Dent: D>0.40 is unacceptable  14.3 Scratch: W ≤ 0.03, L ≤ 10 is acceptable,  0.03 <w 0.10,="" 10="" 2="" acceptable="" between="" defects="" distance="" is="" l="" mm.="" more="" should="" than="" w="" ≤="">0.10 is unacceptable.</w>			
15	РСВ	<ul><li>15.1 No distortion or contamination on PCB terminals.</li><li>15.2 All components on PCB must same as documented on the BOM/component layout.</li><li>15.3 Follow IPC-A-600F.</li></ul>			
16	Soldering	Follow IPC-A-610C standard			

17	Electrical Defect (Major defect)	The below defects must be rejected.  17.1 Missing vertical / horizontal segment,  17.2 Abnormal Display.  17.3 No function or no display.  17.4 Current exceeds product specifications.  17.5 LCD viewing angle defect.  17.6 No Backlight.  17.7 Dark Backlight.  17.8 Touch Panel no function.
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Remark: LCD Panel Broken shall be rejected. Defect out of LCD viewing area is acceptable.

#### 10.7 Classification of Defects

- 10.7.1 Visual defects (Except no / wrong label) are treated as minor defect and electrical defect is major.
- 10.7.2 Two minor defects are equal to one major in lot sampling inspection.

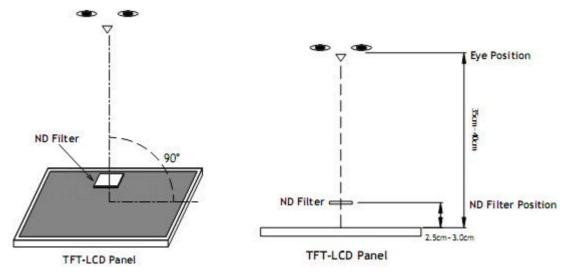
## 10.8 Identification/marking criteria

Any unit with illegible / wrong /double or no marking/ label shall be rejected.

## 10.9 Packaging

- 10.9.1 There should be no damage of the outside carton box, each packaging box should have one identical label.
- 10.9.2 Modules inside package box should have compliant mark.
- 10.9.3 All direct package materials shall offer ESD protection

Note1:Bright dot is defined as the defective area of the dot is larger than 50% of one sub-pixel area.



Bright dot: The bright dot size defect at black display pattern. It can be recognized by 2% transparency of filter when the distance between eyes and panel is  $350 \text{mm} \pm 50 \text{mm}$ .

Dark dot: Cyan, Magenta or Yellow dot size defect at white display pattern. It can be recognized by 5% transparency of filter when the distance between eyes and panel is  $350 \text{mm} \pm 50 \text{mm}$ .

**Note2:** Mura on display which appears darker / brighter against background brightness on parts of display area.

# 11. Reliability Specification

No	Item	Condition	Quantity	Criteria
1	High Temperature Operating	70℃, 96Hrs	2	GB/T2423.2 -2008
2	Low Temperature Operating	-20℃, 96Hrs	2	GB/T2423.1 -2008
3	High Humidity	50℃, 90%RH, 96Hrs	2	GB/T2423.3 -2006
4	High Temperature Storage	80℃, 96Hrs	2	GB/T2423.2 -2008
5	Low Temperature Storage	-30℃, 96Hrs	2	GB/T2423.1 -2008
6	Thermal Cycling Test	-20℃, 60min~70℃, 60min, 20 cycles.	2	GB/T2423.22 -2012
7	Packing vibration	Frequency range:10Hz~50Hz Acceleration of gravity:5G X,Y,Z 30 min for each direction.	2	GB/T5170.14 -2009
8	Electrical Static Discharge	Air: $\pm$ 4KV 150pF/330 $\Omega$ 5 times	2	GB/T17626.2
	Lieutical Static Discharge	Contact: $\pm$ 2KV 150pF/330 $\Omega$ 5 times	2	-2006
9	Drop Test (Packaged)	Height:80 cm,1 corner, 3 edges, 6 surfaces.	2	GB/T2423.8 -1995

Note1. No defection cosmetic and operational function allowable.

Note2. Total current Consumption should be below double of initial value

## 12. Precautions and Warranty

#### 12.1. Safety

12.1.1 The liquid crystal in the LCD is poisonous. Do not put it in your mouth. If the liquid crystal touches your skin or clothes, wash it off immediately using soap and water.

12.1.2 Since the liquid crystal cells are made of glass, do not apply strong impact on them. Handle with care.

#### 12.2. Handling

12.2.1 Reverse and use within ratings in order to keep performance and prevent damage.

12.2.2 Do not wipe the polarizer with dry cloth, as it might cause scratch. If the surface of the LCD needs to be cleaned, wipe it swiftly with cotton or other soft cloth soaked with petroleum IPA, do not use other chemicals.

#### 12.3.Storage

12.3.1. Do not store the LCD module beyond the specified temperature ranges.

12.3.2. Strong light exposure causes degradation of polarizer and color filter

#### 12.4. Metal Pin (Apply to Products with Metal Pins)

12.4.1. Pins of LCD and Backlight

12.4.1.1 Solder tip can touch and press on the tip of Pin LEAD during the soldering

12.4.1.2 Recommended Soldering Conditions

Solder Type: Sn96.3~94-Ag3.3~4.3-Cu0.4~1.1

Maximum Solder Temperature: 370 ℃

Maximum Solder Time: 3s at the maximum temperature

Recommended Soldering Temp: 350±20 ℃

Typical Soldering Time: ≤3s

12.4.1.3 Solder Wetting



Solder Pin Lead
Not Recommended

12.4.2. Pins of EL

12.4.2.1 Solder tip can touch and press on the tip of EL leads during soldering.

12.4.2.2 No Solder Paste on the soldering pad on the motherboard is recommended.

12.4.2.3 Recommended Soldering Conditions

Solder type: Nippon Alimit Leadfree SR-34, size 0.5mm

Recommended Solder Temperature: 270~290 ℃

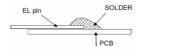
Typical Soldering Time: ≤2s

Minimum solder distance from EL lamp (body):2.0mm

12.4.2.4 No horizontal press on the EL leads during soldering.

12.4.2.5 180° bend EL leads three times is not allowed.

#### 12.4.2.6 Solder Wetting



EL pin SOLDER PCB

Recommended

Not Recommended

12.4.2.7 The type of the solder iron:





Recommended

Not Recommended

12.4.2.8 Solder Pad



#### 12.5. Operation

- 12.5.1. Do not drive LCD with DC voltage
- 12.5.2. Response time will increase below lower temperature
- 12.5.3. Display may change color with different temperature
- 12.5.4. Mechanical disturbance during operation, such as pressing on the display area, may cause the segments to appear "fractured".
- 12.5.5. Do not connect or disconnect the LCM to or from the system when power is on.
- 12.5.6. Never use the LCM under abnormal condition of high temperature and high humidity.
- 12.5.7. Module has high frequency circuits. Sufficient suppression to the electromagnetic interface shall be done by system manufacturers. Grounding and shielding methods may be important to minimize the interference.
- 12.5.8. Do not display the fixed pattern for long time (we suggest the time not longer than one hour) because it may develop image sticking due to the TFT structure.

#### 12.6. Static Electricity

- 12.6.1. CMOS LSIs are equipped in this unit, so care must be taken to avoid the electro-static charge, by ground human body, etc.
- 12.6.2. The normal static prevention measures should be observed for work clothes and benches.
- 12.6.3. The module should be kept into anti-static bags or other containers resistant to static for storage.

#### 12.7. Limited Warranty

- 12.7.1. Our warranty liability is limited to repair and/or replacement. We will not be responsible for any consequential loss.
- 12.7.2. If possible, we suggest customer to use up all modules in six months. If the module storage time over twelve months, we suggest that recheck it before the module be used.
- 12.7.3. After the product shipped, any product quality issues must be feedback within three months, otherwise, we will not be responsible for the subsequent or consequential events.

# 13. Packaging

TBD

## 14. Outline Drawing

